



SLLS552D - DECEMBER 2002 - REVISED APRIL 2005

EXTENDED COMMON-MODE RS-485 TRANSCEIVERS

FEATURES

- Common-Mode Voltage Range (-20 V to 25 V)
 More Than Doubles TIA/EIA-485 Requirement
- Receiver Equalization Extends Cable Length, Signaling Rate (HVD23, HVD24)
- Reduced Unit-Load for up to 256 Nodes
- Bus I/O Protection to Over 16-kV HBM
- Failsafe Receiver for Open-Circuit, Short-Circuit and Idle-Bus Conditions
- Low Standby Supply Current 1-μA Max
- More Than 100 mV Receiver Hysteresis

APPLICATIONS

- Long Cable Solutions
 - Factory Automation
 - Security Networks
 - Building HVAC
- Severe Electrical Environments
 - Electrical Power Inverters
 - Industrial Drives
 - Avionics

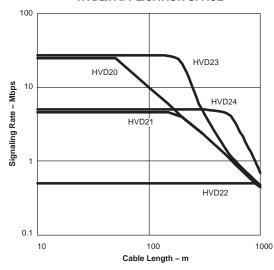
DESCRIPTION

The transceivers in the HVD2x family offer performance far exceeding typical RS-485 devices. In addition to meeting all requirements of the TIA/EIA-485-A standard, the HVD2x family operates over an extended range of common-mode voltage, and has features such as high ESD protection, wide receiver hysteresis, and failsafe operation. This family of devices is ideally suited for long-cable networks, and other applications where the environment is too harsh for ordinary transceivers.

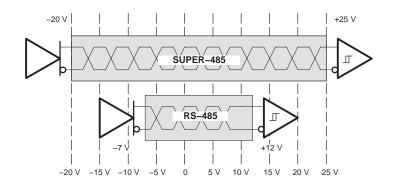
These devices are designed for bidirectional data transmission on multipoint twisted-pair cables. Example applications are digital motor controllers, remote sensors and terminals, industrial process control, security stations, and environmental control systems.

These devices combine a 3-state differential driver and a differential receiver, which operate from a single 5-V power supply. The driver differential outputs and the receiver differential inputs are connected internally to form a differential bus port that offers minimum loading to the bus. This port features an extended common-mode voltage range making the device suitable for multipoint applications over long cable runs.

HVD2x APPLICATION SPACE



HVD2x Devices Operate Over a Wider Common-Mode Voltage Range



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.







These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

DESCRIPTION (continued)

The 'HVD20 provides high signaling rate (up to 25 Mbps) for interconnecting networks of up to 64 nodes.

The 'HVD21 allows up to 256 connected nodes at moderate data rates (up to 5 Mbps). The driver output slew rate is controlled to provide reliable switching with shaped transitions which reduce high-frequency noise emissions.

The 'HVD22 has controlled driver output slew rate for low radiated noise in emission-sensitive applications and for improved signal quality with long stubs. Up to 256 'HVD22 nodes can be connected at signaling rates up to 500 kbps.

The 'HVD23 implements receiver equalization technology for improved jitter performance on differential bus applications with data rates up to 25 Mbps at cable lengths up to 160 meters.

The 'HVD24 implements receiver equalization technology for improved jitter performance on differential bus applications with data rates in the range of 1 Mbps to 10 Mbps at cable lengths up to 1000 meters.

The receivers also include a failsafe circuit that provides a high-level output within 250 microseconds after loss of the input signal. The most common causes of signal loss are disconnected cables, shorted lines, or the absence of any active transmitters on the bus. This feature prevents noise from being received as valid data under these fault conditions. This feature may also be used for Wired-Or bus signaling.

The SN65HVD2X devices are characterized for operation over the temperature range of -40°C to 85°C.

PRODUCT SELECTION GUIDE

| PART NUMBERS | CABLE LENGTH AND SIGNALING RATE ⁽¹⁾ | NODES | MARKING |
|--------------|---|-----------|-----------------------|
| SN65HVD20 | Up to 50 m at 25 Mbps | Up to 64 | D: VP20 P: 65HVD20 |
| SN65HVD21 | Up to 150 m at 5 Mbps (with slew rate limit) | Up to 256 | D: VP21 P: 65HVD21 |
| SN65HVD22 | Up to1200 m at 500 kbps (with slew rate limit) | Up to 256 | D: VP22 P: 65HVD22 |
| SN65HVD23 | Up to 160 m at 25 Mbps (with receiver equalization) | Up to 64 | D: VP23 P: 65HVD23 |
| SN65HVD24 | Up to 500 m at 3 Mbps (with receiver equalization) | Up to 256 | D: VP24 P: 65HVD24 |

⁽¹⁾ Distance and signaling rate predictions based upon Belden 3105A cable and 15% eye pattern jitter.

AVAILABLE OPTIONS

| PLASTIC THROUGH-HOLE P-PACKAGE (JEDEC MS-001) | PLASTIC SMALL-OUTLINE ⁽¹⁾ D-PACKAGE (JEDEC MS-012) |
|---|---|
| SN65HVD20P | SN65HVD20D |
| SN65HVD21P | SN65HVD21D |
| SN65HVD22P | SN65HVD22D |
| SN65HVD23P | SN65HVD23D |
| SN65HVD24P | SN65HVD24D |

Add R suffix for taped and reeled carriers.





DRIVER FUNCTION TABLE

| HVD20, HVD21, HVD22 | | | | | HVD23, HVD2 | 24 | |
|---------------------|--------|-----|------|-------|-------------|-----|------|
| INPUT | ENABLE | OUT | PUTS | INPUT | ENABLE | OUT | PUTS |
| D | DE | A B | | D | DE | Α | В |
| Н | Н | Н | L | Н | Н | Н | L |
| L | Н | L | Н | L | Н | L | Н |
| Х | L | Z | Z | Х | L | Z | Z |
| X | OPEN | Z | Z | Х | OPEN | Z | Z |
| OPEN | Н | Н | L | OPEN | Н | L | Н |

H = high level, L = low level, X = don't care, Z = high impedance (off), ? = indeterminate

RECEIVER FUNCTION TABLE

| DIFFERENTIAL INPUT | ENABLE | OUTPUT |
|---|--------|----------------|
| $V_{ID} = (V_A - V_B)$ | RE | R |
| 0.2 V ≤ V _{ID} | L | Н |
| $-0.2 \text{ V} < \text{V}_{\text{ID}} < 0.2 \text{ V}$ | L | H (see Note A) |
| $V_{ID} \leq -0.2 V$ | L | L |
| X | Н | Z |
| X | OPEN | Z |
| Open circuit | L | Н |
| Short Circuit | L | Н |
| Idle (terminated) bus | L | Н |

H = high level, L= low level, Z = high impedance (off)

NOTE A: If the differential input V_{ID} remains within the transition range for more than 250 μs, the integrated failsafe circuitry detects a bus fault, and set the receiver output to a high state. See Figure 15.

ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range unless otherwise noted(1)

| | | | SN65HVD2X | | |
|--------------------------------------|---|-----------|---------------|--|--|
| Supply voltage(2), V _{CC} | Supply voltage ⁽²⁾ , V _{CC} | | | | |
| Voltage at any bus I/O terr | minal | | −27 V to 27 V | | |
| Voltage input, transient pul | –60 V to 60 V | | | | |
| Voltage input at any D, DE | Voltage input at any D, DE or RE terminal | | | | |
| Receiver output current, Ic | Receiver output current, IO | | | | |
| | Liveran Bady Madal(3) | A, B, GND | 16 kV | | |
| Flactor et affa affa ala anno | Human Body Model(3) | All pins | 5 kV | | |
| Electrostatic discharge | Charged-Device Model ⁽⁴⁾ | All pins | 1.5 kV | | |
| | Machine Model ⁽⁵⁾ | All pins | 200 V | | |
| Continuous total power dis | Continuous total power dissipation | | | | |
| Junction temperature, T _J | Junction temperature, TJ | | | | |

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

⁽²⁾ All voltage values, except differential I/O bus voltages, are with respect to network ground terminal.

⁽³⁾ Tested in accordance with JEDEC Standard 22, Test Method A114-A.

⁽⁴⁾ Tested in accordance with JEDEC Standard 22, Test Method C101.

⁽⁵⁾ Tested in accordance with JEDEC Standard 22, Test Method A115-A.

SLLS552D - DECEMBER 2002 - REVISED APRIL 2005



POWER DISSIPATION RATINGS

| PACKAGE | | T _A ≤ 25°C POWER RATING | DERATING FACTOR(3) ABOVE T _A = 25°C | T _A = 70°C POWER RATING | T _A = 85°C POWER RATING |
|---------|-----------------------|---------------------------------------|---|---------------------------------------|---------------------------------------|
| | Low-K(1) | 577 mW | 4.62 mW/°C | 369 mW | 300 mW |
| D | High-K ⁽²⁾ | 913 mW | 7.3 mW/°C | 584 mW | 474 mW |
| | Low-K(1) | 984 mW | 7.87 mW/°C | 630 mW | 512 mW |
| Р | High-K ⁽²⁾ | 1344 mW | 10.8 mW/°C | 860 mW | 700 mW |

⁽¹⁾ In accordance with the Low-K thermal metric definitions of EIA/JESD51–3.

THERMAL CHARACTERISTICS

| | PARAMETER | | | TEST CONDITIONS | | VALUE | UNITS | | |
|-----------------|---|------------|-------|--|----------|-------|--------|-----|--|
| | O harding to be and the modern interest | | D | | | 86.2 | | | |
| θЈВ | Junction-to-board thermal res | istance | Р | | | 56 | 0000 | | |
| | | | D | | | 47.1 | °C/W | | |
| θJC | Junction-to-case thermal resis | stance | Р | | | 54 | | | |
| | | | HVD20 | V _{CC} = 5 V, T _J = 25°C, | 25 Mbps | 295 | | | |
| | | | HVD21 | $R_L = 54 \Omega$, $C_L = 50 pF$ (driver), 5 Mbps | 5 Mbps | 260 | | | |
| | | Typical | HVD22 | | 233 | | | | |
| | | | HVD23 | Driver and receiver enabled | 25 Mbps | 302 | | | |
| | | | HVD24 | | 5 Mbps | 267 | 144 | | |
| PD | Device power dissipation | | HVD20 | | 25 Mbps | 408 | mW | | |
| | | | HVD21 | | 5 Mbps | 342 | | | |
| | | Worst case | HVD22 | C _L = 50 pF, C _L = 15 pF (receiver), 50% Duty cycle square-wave signal, | 500 kbps | 300 | | | |
| | | | HVD23 | Driver and receiver enabled | 25 Mbps | 417 | | | |
| | | | HVD24 | | HVD24 | | 5 Mbps | 352 | |
| T _{SD} | Thermal shut-down junction to | emperature | | | | 170 | °C | | |

RECOMMENDED OPERATING CONDITIONS

| | | MIN | NOM | MAX | UNIT |
|--|---------------------|------|-----|-----|------|
| Supply voltage, V _{CC} | | 4.5 | 5 | 5.5 | V |
| Voltage at any bus I/O terminal | A, B | -20 | | 25 | V |
| High-level input voltage, VIH | DE 000 | | | VCC | ., |
| Low-level input voltage, V _{IL} | D, DE, RE | 0 | | 0.8 | V |
| Differential input voltage, VID | A with respect to B | -25 | | 25 | V |
| Outract comment | Driver | -110 | | 110 | ^ |
| Output current | Receiver | -8 | | 8 | mA |
| Operating free-air temperature, TA | (1) | -40 | | 85 | °C |
| Junction temperature, TJ | | -40 | | 130 | °C |

⁽¹⁾ Maximum free-air temperature operation is allowed as long as the device recommended junction temperature is not exceeded.

⁽²⁾ In accordance with the High-K thermal metric definitions of EIA/JESD51–7.
(3) This is the inverse of the junction-to-ambient thermal resistance when board-mounted and with no air flow.



SLLS552D – DECEMBER 2002 – REVISED APRIL 2005

DRIVER ELECTRICAL CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)(1)

| | PARAMETER | TEST CONDITIONS | MIN | TYP(1) | MAX | UNIT |
|------------------------|---|--|------|-------------|-------|------|
| VIK | Input clamp voltage | I _I = -18 mA | -1.5 | 0.75 | | V |
| VO | Open-circuit output voltage | A or B, No load | 0 | | VCC | V |
| | | No load (open circuit) | 3.3 | 4.2 | Vcc | |
| IVOD(SS) | Steady-state differential output voltage magnitude | $R_L = 54 \Omega$, See Figure 1 | 1.8 | 2.5 | | V |
| , , | magnitude | With common-mode loading, See Figure 2 | 1.8 | | | |
| Δ V _{OD} (SS) | Change in steady-state differential output voltage between logic states | See Figure 1 and Figure 3 | | | 0.1 | V |
| Voc(ss) | Steady-state common-mode output voltage | See Figure 1 | 2.1 | 2.5 | 2.9 | V |
| ΔV _{OC} (SS) | Change in steady-state common-mode output voltage, VOC(H) - VOC(L) | See Figure 1 and Figure 4 | -0.1 | | 0.1 | V |
| VOC(PP) | Peak-to-peak common-mode output voltage, VOC(MAX) - VOC(MIN) | $R_L = 54 \Omega$, $C_L = 50 pF$, See Figure 1 and Figure 4 | | 0.35 | | V |
| VOD(RING) | Differential output voltage over and under shoot | $R_L = 54 \Omega$, $C_L = 50 pF$, See Figure 5 | | | 10% | |
| Ц | Input current | D, DE | -100 | | 100 | μΑ |
| I _{O(OFF)} | Output current with power off | V _{CC} <= 2.5 V | | ceiver line | input | |
| loz | High impedance state output current | DE at 0 V | | current | · | |
| los | Short-circuit output current | $V_O = -20 \text{ V}$ to 25 V, See Figure 9 | -250 | | 250 | mA |
| C _{OD} | Differential output capacitance | | Se | e receiver | Cl | |

⁽¹⁾ All typical values are at $V_{CC} = 5 \text{ V}$ and 25°C .

DRIVER SWITCHING CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

| | PARAMETER | TEST C | ONDITIONS | MIN | TYP(1) | MAX | UNIT |
|-------------------------|---|------------------------------|--------------|-----|--------|-----|------|
| ^t PLH | Differential output propagation delay, low-to- high | $R_1 = 54 \Omega$ | HVD20, HVD23 | 6 | 10 | 20 | |
| 1 | 3 | $C_{L}^{-} = 50 \text{ pF},$ | HVD21, HVD24 | 20 | 32 | 60 | ns |
| ^t PHL | Differential output propagation delay, high-to-low | See Figure 3 | HVD22 | 160 | 280 | 500 | |
| t _r | Differential output rise time | $R_{I} = 54 \Omega$ | HVD20, HVD23 | 2 | 6 | 12 | |
| 1 | | $C_{L} = 50 \text{ pF},$ | HVD21, HVD24 | 20 | 40 | 60 | ns |
| tf | Differential output fall time | See Figure 3 | HVD22 | 200 | 400 | 600 | |
| ^t PZH | Propagation delay time, high-impedance-to-high-level output | | HVD20, HVD23 | | | 40 | |
| 17211 | repagation asia, unis, riigir imposatios to riigir is to calput | RE at 0 V, See Figure 6 | HVD21, HVD24 | | | 100 | ns |
| ^t PHZ | Propagation delay time, high-level-output-to-high-impedance | See rigule o | HVD22 | | | 300 | |
| tPZL | Propagation delay time, high-impedance-to-low-level output | == | HVD20, HVD23 | | | 40 | |
| 1 22 | | RE at 0 V, See Figure 7 | HVD21, HVD24 | | | 100 | ns |
| ^t PLZ | Propagation delay time, low-level-output-to-high-impedance | See rigule r | HVD22 | | | 300 | |
| ^t d(standby) | Time from an active differential output to standby | PE at Vac S | oo Eiguro 9 | | | 2 | μs |
| ^t d(wake) | Wake-up time from standby to an active differential output | RE at V _{CC} , S | see Figure o | | | 8 | μs |
| | | HVD20, HVD23 | | | | 2 | • |
| tsk(p) | Pulse skew tpLH - tpHL | HVD21, HVD24 | | | | 6 | ns |
| | | HVD22 | | | 50 | | |

⁽¹⁾ All typical values are at $V_{CC} = 5 \text{ V}$ and 25°C .





RECEIVER ELECTRICAL CHARACTERISTICS

over recommended operating conditions

| PARAMETER | | TEST (| TEST CONDITIONS | | | MAX | UNIT |
|---------------------|---|---------------------------------------|--|------|------|------|------|
| V _{IT(+)} | Positive-going differential input voltage threshold | Coo Figure 40 | $V_O = 2.4 \text{ V}, I_O = -8 \text{ mA}$ | | 60 | 200 | m)/ |
| VIT(-) | Negative-going differential input voltage threshold | See Figure 10 | $V_O = 0.4 \text{ V}, I_O = 8 \text{ mA}$ | -200 | -60 | | mV |
| VHYS | Hysteresis voltage (V _{IT+} - V _{IT-}) | | | 100 | 130 | | mV |
| \/ \ | Positive-going differential input failsafe voltage | Soo Figure 15 | $V_{CM} = -7 \text{ V to } 12 \text{ V}$ | 40 | 120 | 200 | mV |
| V _{IT(F+)} | threshold | See Figure 15 | V _{CM} = -20 V to 25 V | | 120 | 250 | IIIV |
| \/ | Negative-going differential input failsafe voltage | See Figure 15 | $V_{CM} = -7 \text{ V to } 12 \text{ V}$ | -200 | -120 | -40 | mV |
| VIT(F-) | threshold | See Figure 15 | $V_{CM} = -20 \text{ V to } 25 \text{ V}$ | -250 | -120 | | IIIV |
| VIK | Input clamp voltage | I _I = -18 mA | I _I = -18 mA | | | | V |
| Vон | High-level output voltage | $V_{ID} = 200 \text{ mV}, I_{OH}$ | = -8 mA, See Figure 11 | 4 | | | V |
| VOL | Low-level output voltage | $V_{ID} = -200 \text{ mV}, I_{OI}$ | L = 8 mA, See Figure 11 | | | 0.4 | V |
| | | $V_1 = -7 \text{ to } 12 \text{ V},$ | HVD20, HVD23 | -400 | | 500 | |
| lum. | Due input current (neuron en en neuron eff) | Other input = 0 V | HVD21, HVD22, HVD24 | -100 | | 125 | |
| I(BUS) | Bus input current (power on or power off) | $V_1 = -20 \text{ to } 25 \text{ V},$ | HVD20, HVD23 | -800 | | 1000 | μΑ |
| | | Other input = 0 V | HVD21, HVD22, HVD24 | -200 | | 250 | |
| II | Input current | RE | | -100 | | 100 | μΑ |
| D. | lanut registance | HVD20, 23 HVD21, 22, 24 | | 24 | | | kO |
| R _I | Input resistance | | | 96 | | | kΩ |
| C _{ID} | Differential input capacitance | $V_{ID} = 0.5 + 0.4 \sin \theta$ | e (2π x 1.5 x 10 ⁶ t) | | | 20 | pF |

⁽¹⁾ All typical values are at 25°C.

RECEIVER SWITCHING CHARACTERISTICS

over recommended operating conditions

| | PARAMETER | TEST | TEST CONDITIONS | | | MAX | UNIT |
|-------------------------|--|----------------|--------------------------|----|-----|-----|------|
| ^t PLH | Propagation delay time, low-to-high level output | Can Firmer 44 | HVD20, HVD23 | | 16 | 35 | |
| tPHL | Propagation delay time, high-to-low level output | See Figure 11 | HVD21, HVD22, HVD24 | | 25 | 50 | ns |
| t _r | Receiver output rise time | Coo Figure 44 | | | 2 | 4 | |
| t _f | Receiver output fall time | See Figure 11 | | | 2 | 4 | ns |
| ^t PZH | Receiver output enable time to high level | Con Firmer 40 | | | 90 | 120 | 20 |
| ^t PHZ | Receiver output disable time from high level | See Figure 12 | | 16 | 35 | ns | |
| tPZL | Receiver output enable time to low level | See Figure 13 | | 90 | 120 | 20 | |
| tPLZ | Receiver output disable time from low level | See Figure 13 | | | 16 | 35 | ns |
| ^t r(standby) | Time from an active receiver output to standby | | | | | 2 | |
| tr(wake) | Wake-up time from standby to an active receiver output | See Figure 14, | See Figure 14, DE at 0 V | | | 8 | μs |
| tsk(p) | Pulse skew tpLH - tpHL | | | | | 5 | ns |
| tp(set) | Delay time, bus fail to failsafe set | See Figure 15, | pulse rate = 1 kHz | | 250 | 350 | μs |
| tp(reset) | Delay time, bus recovery to failsafe reset | See Figure 15, | puise rate = 1 kmz | | | 50 | ns |





RECEIVER EQUALIZATION CHARACTERISTICS(1)

over recommended operating conditions

| F | PARAMETER | TEST CON | DITIONS | | | MIN | TYP(2) | MAX | UNIT |
|--------|------------------------------------|--|---------|---------|-------|-----|--------|-----|------|
| | | | | 0 m | HVD23 | | 2 | | |
| | | | | 100 | HVD20 | | 6 | | |
| | | | | 100 m | HVD23 | | 3 | | |
| | | | 25 Mbps | 150 m | HVD20 | | 15 | | |
| | | | | 130 111 | HVD23 | | 4 | | |
| | | | | 200 m | HVD20 | | 27 | | |
| | | | | 200 111 | HVD23 | | 8 | | |
| | | Pseudo-random NRZ code with a bit pattern length of 2 ¹⁶ – 1, Beldon 3105A cable, See Figure 27 | 10 Mbps | 200 m | HVD20 | | 22 | | |
| | | | | 200 111 | HVD23 | | 8 | | |
| | Dools to mosts | | | 250 m | HVD20 | | 34 | | |
| tj(pp) | Peak-to-peak eye-pattern jitter | | | 230 111 | HVD23 | | 15 | | ns |
| | | | | 300 m | HVD20 | | 49 | | |
| | | | | 300 111 | HVD23 | | 27 | | |
| | | | | 500 m | HVD21 | | 128 | | |
| | | | 5 Mbps | 300 111 | HVD24 | | 18 | | |
| | | | | | HVD20 | | 93 | | |
| | | | 2 Mbpo | 500 m | HVD21 | | 103 | | |
| | | | 3 Mbps | 300 111 | HVD23 | | 90 | | |
| | | | | | HVD24 | | 16 | | |
| | | | 1 Mbpo | 1000 m | HVD21 | | 216 | · | |
| | | | 1 Mbps | 1000 m | HVD24 | | 62 | | |

⁽¹⁾ The HVD20 and HVD21 do not have receiver equalization, but are specified for comparison.

SUPPLY CURRENT

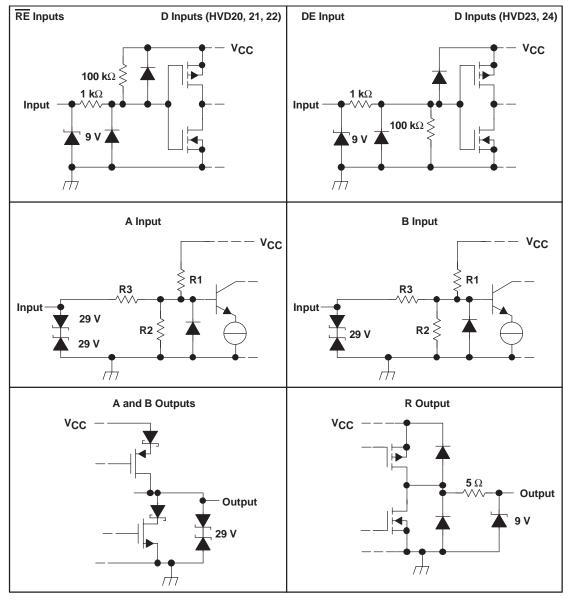
over recommended operating conditions (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT | |
|-----|----------------|---|--------------|-----|-----|------|----|
| | | | HVD20 | | 6 | 9 | |
| | | Divine analysis (DE at)/a a \ Danair an analysis (DE at 0.)/ | HVD21 | | 8 | 12 | |
| | | Driver enabled (DE at V _{CC}), Receiver enabled (RE at 0 V) No load, V _I = 0 V or V _{CC} | HVD22 | | 6 | 9 | mA |
| | | 110 1000, 7 = 0 7 01 7 00 | HVD23 | | 7 | 11 | |
| | | | HVD24 | | 10 | 14 | |
| | | | HVD20 | | 5 | 8 | |
| | | Driver eachly (PE of W.). Describes dischied (PE of W.). | HVD21 | | 7 | 11 | mA |
| | | Driver enabled (DE at V _{CC}), Receiver disabled (RE at V _{CC}) No load, V _I = 0 V or V _{CC} | HVD22 | | 5 | 8 | |
| ICC | Supply current | No load, V = 0 V OF VCC | HVD23 | | 5 | 9 | |
| | | | HVD24 | | 8 | 12 | |
| | | | HVD20 | | 4 | 7 | |
| | | B: | HVD21 | | 5 | 8 | |
| | | Driver disabled (DE at 0 V), Receiver enabled (RE at 0 V) No load | HVD22 | | 4 | 7 | mA |
| | | No load | HVD23 | | 4.5 | 9 | |
| | | | HVD24 | | 5.5 | 10 | |
| | | Driver disabled (DE at 0 V), Receiver disabled (RE at V_{CC}) D open | All HVD2x | | | 1 | μА |

⁽²⁾ All typical values are at $V_{CC} = 5 \text{ V}$, and temperature = 25°C .



EQUIVALENT INPUT AND OUTPUT SCHEMATIC DIAGRAMS



| | R1/R2 | R3 |
|---------------|---------------|----------------|
| HVD20, 23 | 9 k Ω | 45 k Ω |
| HVD21, 22, 24 | 36 k Ω | 180 k Ω |



PARAMETER MEASUREMENT INFORMATION

NOTES:

Test load capacitance includes probe and jig capacitance (unless otherwise specified). Signal generator characteristics: rise and fall time < 6 ns, pulse rate 100 kHz, 50% duty cycle, $Z_0 = 50 \Omega$ (unless otherwise specified)

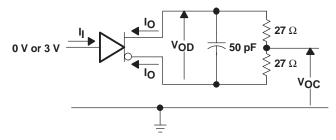


Figure 1. Driver Test Circuit, V_{OD} and V_{OC} Without Common-Mode Loading

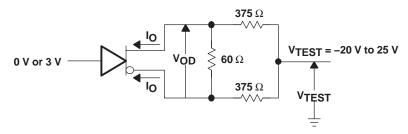


Figure 2. Driver Test Circuit, VOD With Common-Mode Loading

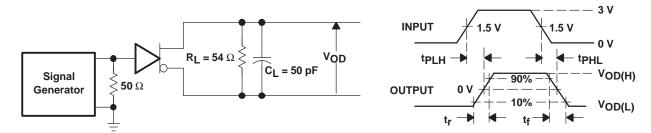


Figure 3. Driver Switching Test Circuit and Waveforms

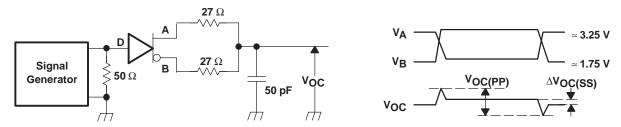
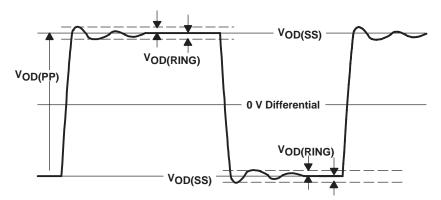


Figure 4. Driver V_{OC} Test Circuit and Waveforms





NOTE: $V_{OD(RING)}$ is measured at four points on the output waveform, corresponding to overshoot and undershoot from the $V_{OD(H)}$ and $V_{OD(L)}$ steady state values.

Figure 5. V_{OD(RING)} Waveform and Definitions

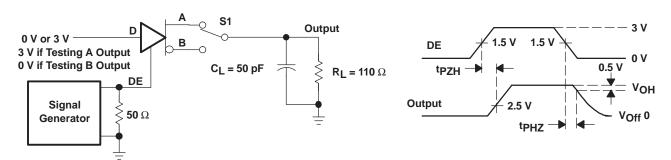


Figure 6. Driver Enable/Disable Test, High Output

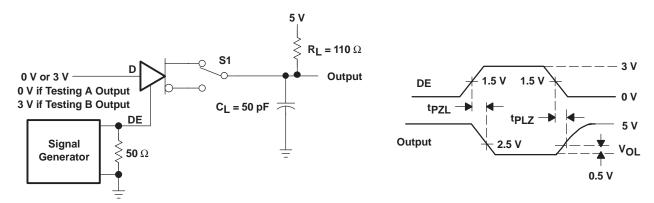


Figure 7. Driver Enable/Disable Test, Low Output

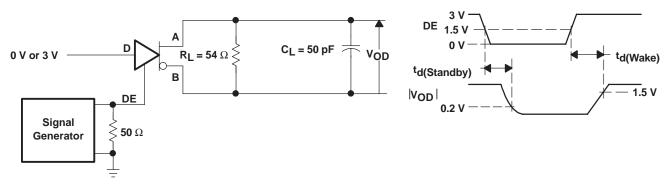


Figure 8. Driver Standby/Wake Test Circuit and Waveforms



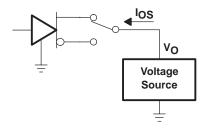


Figure 9. Driver Short-Circuit Test

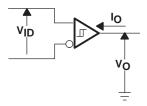


Figure 10. Receiver DC Parameter Definitions

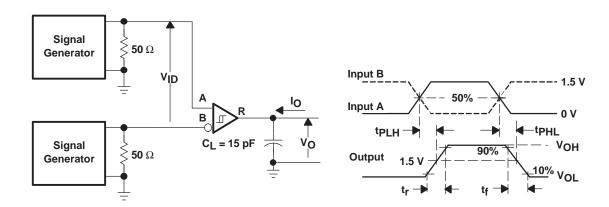


Figure 11. Receiver Switching Test Circuit and Waveforms

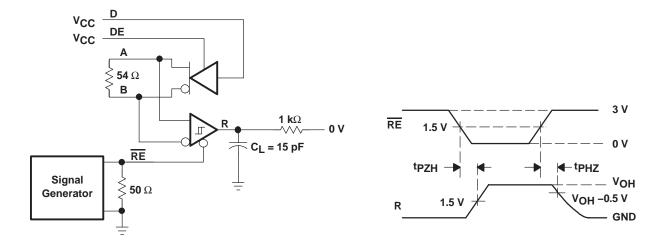


Figure 12. Receiver Enable Test Circuit and Waveforms, Data Output High



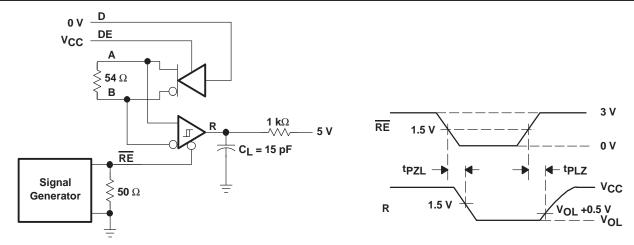


Figure 13. Receiver Enable Test Circuit and Waveforms, Data Output Low

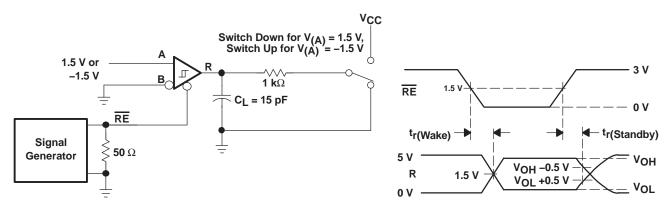


Figure 14. Receiver Standby and Wake Test Circuit and Waveforms

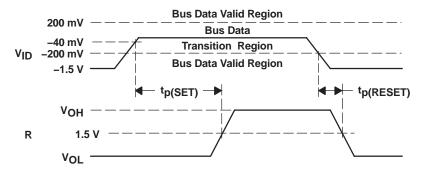


Figure 15. Receiver Active Failsafe Definitions and Waveforms

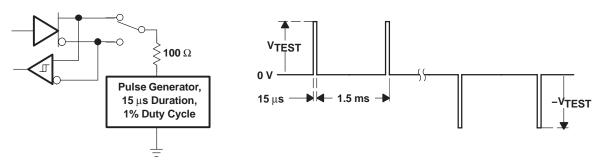
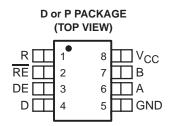


Figure 16. Test Circuit and Waveforms, Transient Overvoltage Test

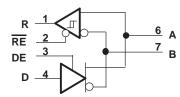


PIN ASSIGNMENTS

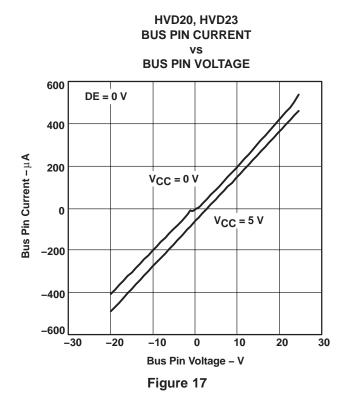


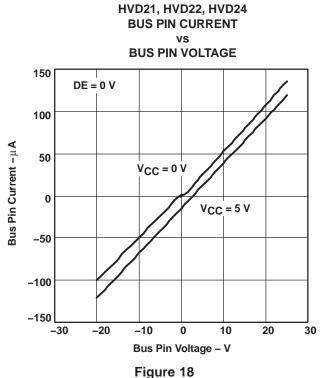
LOGIC DIAGRAM

POSITIVE LOGIC



TYPICAL CHARACTERISTICS









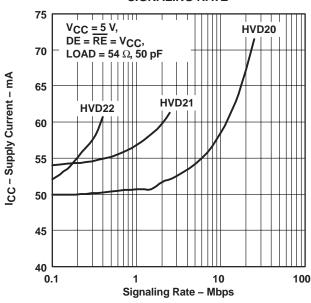


Figure 19

DRIVER DIFFERENTIAL OUTPUT VOLTAGE vs DRIVER LOAD CURRENT

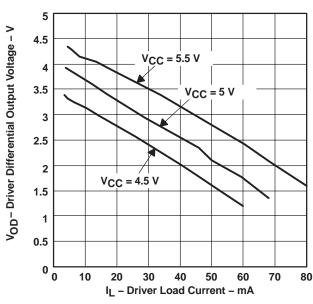


Figure 20

RECEIVER OUTPUT VOLTAGE
vs
DIFFERENTAL INPUT VOLATGE

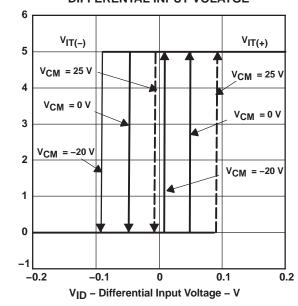
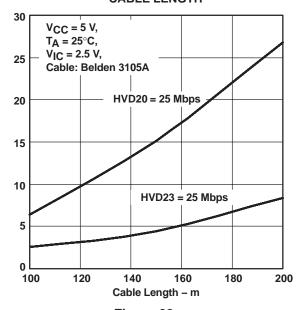


Figure 21

HVD20, HVD23 PEAK-TO-PEAK JITTER vs CABLE LENGTH



Peak-to-Peak Jitter - ns

Figure 22

Vo- Receiver Output Voltage - V

HVD20, HVD23





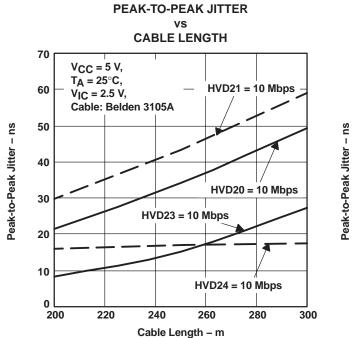
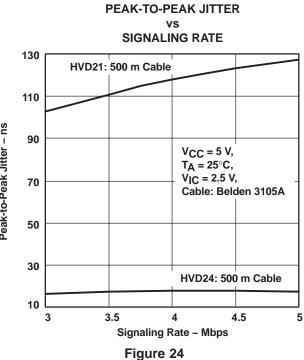


Figure 23

HVD20, HVD21, HVD23, HVD24





APPLICATION INFORMATION

THEORY OF OPERATION

The HVD2x family of devices integrates a differential receiver and differential driver with additional features for improved performance in electrically-noisy, long-cable, or other fault-intolerant applications.

The receiver hysteresis (typically 130 mV) is much larger than found in typical RS-485 transceivers. This helps reject spurious noise signals which would otherwise cause false changes in the receiver output state.

Slew rate limiting on the driver outputs (SN65HVD21, 22, and 24) reduces the high-frequency content of signal edges. This decreases reflections from bus discontinuities, and allows longer stub lengths between nodes and the main bus line. Designers should consider the maximum signaling rate and cable length required for a specific application, and choose the transceiver best matching those requirements.

When DE is low, the differential driver is disabled, and the A and B outputs are in high-impedance states. When DE is high, the differential driver is enabled, and drives the A and B outputs according to the state of the D input.

When \overline{RE} is high, the differential receiver output buffer is disabled, and the R output is in a high-impedance state. When \overline{RE} is low, the differential receiver is enabled, and the R output reflects the state of the differential bus inputs on the A and B pins.

If both the driver and receiver are disabled, (DE low and \overline{RE} high) then all nonessential circuitry, including auxiliary functions such as failsafe and receiver equalization is placed in a low-power standby state. This reduces power consumption to less than 5 μ W. When either enable input is asserted, the circuitry again becomes active.

In addition to the primary differential receiver, these devices incorporate a set of comparators and logic to implement an active receiver failsafe feature. These components determine whether the differential bus signal is valid. Whenever the differential signal is close to zero volts (neither high nor low), a timer initiates, If the differential input remains within the transition range for more than 250 microseconds, the timer expires and set the receiver output to the high state. If a valid bus input (high or low) is received at any time, the receiver output reflects the valid bus state, and the timer is reset.

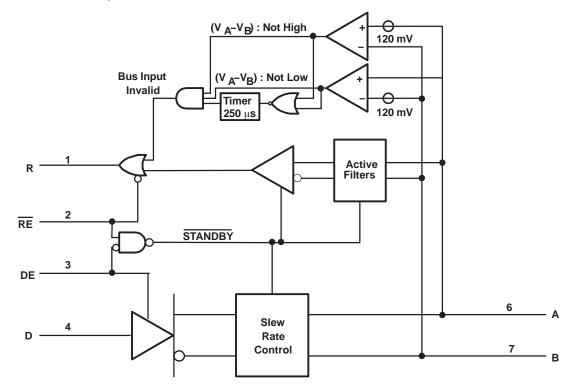


Figure 25. Function Block Diagram



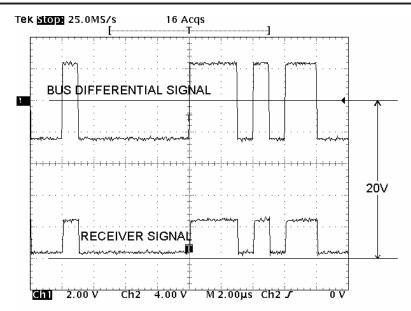


Figure 26. HVD22 Receiver Operation With 20-V Offset on Input Signal

| $ H(s) = k_0 \left[\left(1 - k_1 \right) + \frac{k_1 p_1}{\left(s + p_1 \right)} \right] \left[\left(1 - k_2 \right) + \frac{k_2 p_2}{\left(s + p_2 \right)} \right] \left[\left(1 - k_3 \right) + \frac{k_3 p_3}{\left(s + p_3 \right)} \right] $ | k0 (DC loss) | p1 (MHz) | k1 | p2 (MHz) | k2 | p3 (MHz) | k3 |
|---|--------------------|-------------|-----|-------------|-----|-------------|----|
| Similar to 160m of Belden 3105A | 0.95 | 0.25 | 0.3 | 3.5 | 0.5 | 15 | 1 |
| Similar to 250m of Belden 3105A | 0.9 | 0.25 | 0.4 | 3.5 | 0.7 | 12 | 1 |
| Similar to 500m of Belden 3105A | 0.8 | 0.25 | 0.6 | 2.2 | 1 | 8 | 1 |
| Similar to 1000m of Belden 3105A | 0.6 | 0.3 | 1 | 3 | 1 | 6 | 1 |

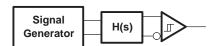


Figure 27. Cable Attenuation Model for Jitter Measurements



INTEGRATED RECEIVER EQUALIZATION USING THE HVD23

Figure 28 illustrates the benefits of integrated receiver equalization as implemented in the HVD23 transceiver. In this test setup, a differential signal generator applied a signal voltage at one end of the cable, which was Belden 3105A twisted-pair shielded cable. The test signal was a pseudo-random bit stream (PRBS) of nonreturn-to-zero (NRZ) data. Channel 1 (top) shows the eye-pattern of the differential voltage at the receiver inputs (after the cable attenuation). Channel 2 (bottom) shows the output of the receiver.

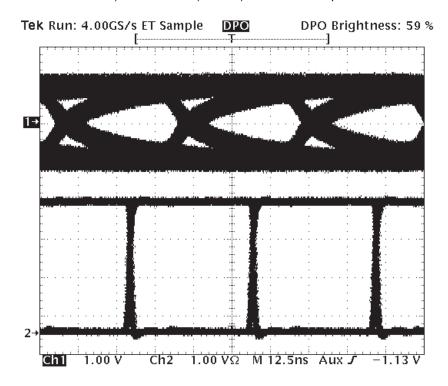


Figure 28. HVD23 Receiver Performance at 25 Mbps Over 150 Meter Cable





INTEGRATED RECEIVER EQUALIZATION USING THE HVD24

Figure 29 illustrates the benefits of integrated receiver equalization as implemented in the HVD24 transceiver. In this test setup, a differential signal generator applied a signal voltage at one end of the cable, which was Belden 3105A twisted-pair shielded cable. The test signal was a pseudo-random bit stream (PRBS) of nonreturn-to-zero (NRZ) data. Channel 1 (top) shows the eye-pattern of the bit stream. Channel 2 (middle) shows the eye-pattern of the differential voltage at the receiver inputs (after the cable attenuation). Channel 3 (bottom) shows the output of the receiver.

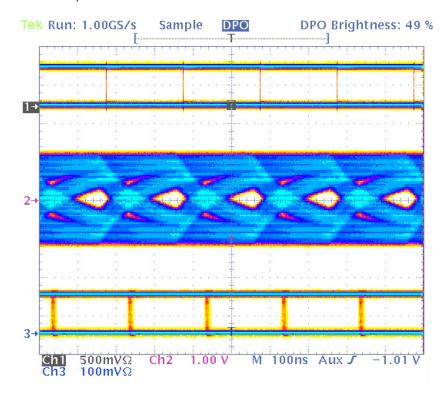


Figure 29. HVD24 Receiver Performance at 5 Mbps Over 500 Meter Cable

SLLS552D - DECEMBER 2002 - REVISED APRIL 2005



NOISE CONSIDERATIONS FOR EQUALIZED RECEIVERS

The simplest way of overcoming the effects of cable losses is to increase the sensitivity of the receiver. If the maximum attenuation of frequencies of interest is 20 dB, increasing the receiver gain by a factor of ten compensates for the cable. However, this means that both signal and noise are amplified. Therefore, the receiver with higher gain is more sensitive to noise and it is important to minimize differential noise coupling to the equalized receiver.

Differential noise is crated when conducted or radiated noise energy generates more voltage on one line of the differential pair than the other. For this to occur from conducted or electric far-field noise, the impedance to ground of the lines must differ.

For noise frequency out to 50 MHz, the input traces can be treated as a lumped capacitance if the receiver is approximately 10 inches or less from the connector. Therefore, matching impedance of the lines is accomplished by matching the lumped capacitance of each.

The primary factors that affect the capacitance of a trace are in length, thickness, width, dielectric material, distance from the signal return path, stray capacitance, and proximity to other conductors. It is difficult to match each of the variables for each line of the differential pair exactly, but a reasonable effort to do so keeps the lines balanced and less susceptible to differential noise coupling.

Another source of differential noise is from near-field coupling. In this situation, an assumption of equal noise-source impedance cannot be made as in the far-field. Familiarly known as crosstalk, more energy from a nearby signal is coupled to one line of the differential pair. Minimization of this differential noise is accomplished by keeping the signal pair close together and physical separation from high-voltage, high-current, or high-frequency signals.

In summary, follow these guidelines in board layout for keeping differential noise to a minimum.

- Keep the differential input traces short.
- Match the length, physical dimensions, and routing of each line of the pair.
- Keep the lines close together.
- Match components connected to each line.
- Separate the inputs from high-voltage, high-frequency, or high-current signals.



PACKAGING INFORMATION

| Orderable Device | Status ⁽¹⁾ | Package Type | Package Drawing | Pins | Package Qty | e Eco Plan ⁽²⁾ | Lead/Ball Finish | MSL Peak Temp ⁽³⁾ |
|------------------|-----------------------|-----------------|--------------------|------|----------------|---------------------------|------------------|------------------------------|
| SN65HVD20D | ACTIVE | SOIC | D | 8 | 75 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN65HVD20DG4 | ACTIVE | SOIC | D | 8 | 75 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN65HVD20DR | ACTIVE | SOIC | D | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN65HVD20DRG4 | ACTIVE | SOIC | D | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN65HVD20P | ACTIVE | PDIP | Р | 8 | 50 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| SN65HVD20PE4 | ACTIVE | PDIP | Р | 8 | 50 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| SN65HVD21D | ACTIVE | SOIC | D | 8 | 75 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN65HVD21DG4 | ACTIVE | SOIC | D | 8 | 75 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN65HVD21DR | ACTIVE | SOIC | D | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN65HVD21DRG4 | ACTIVE | SOIC | D | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN65HVD21P | ACTIVE | PDIP | Р | 8 | 50 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| SN65HVD21PE4 | ACTIVE | PDIP | Р | 8 | 50 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| SN65HVD22D | ACTIVE | SOIC | D | 8 | 75 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN65HVD22DG4 | ACTIVE | SOIC | D | 8 | 75 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN65HVD22DR | ACTIVE | SOIC | D | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN65HVD22DRG4 | ACTIVE | SOIC | D | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN65HVD22P | ACTIVE | PDIP | Р | 8 | 50 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| SN65HVD22PE4 | ACTIVE | PDIP | Р | 8 | 50 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| SN65HVD23D | ACTIVE | SOIC | D | 8 | 75 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN65HVD23DG4 | ACTIVE | SOIC | D | 8 | 75 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN65HVD23DR | ACTIVE | SOIC | D | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN65HVD23DRG4 | ACTIVE | SOIC | D | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN65HVD23P | ACTIVE | PDIP | Р | 8 | 50 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| SN65HVD23PE4 | ACTIVE | PDIP | Р | 8 | 50 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| SN65HVD24D | ACTIVE | SOIC | D | 8 | 75 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |



PACKAGE OPTION ADDENDUM

23-Jul-2007

| Orderable Device | Status ⁽¹⁾ | Package Type | Package Drawing | Pins | Package Qty | Eco Plan ⁽²⁾ | Lead/Ball Finish | MSL Peak Temp ⁽³⁾ |
|------------------|-----------------------|-----------------|--------------------|------|----------------|-------------------------|------------------|------------------------------|
| SN65HVD24DG4 | ACTIVE | SOIC | D | 8 | 75 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN65HVD24DR | ACTIVE | SOIC | D | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN65HVD24DRG4 | ACTIVE | SOIC | D | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN65HVD24P | ACTIVE | PDIP | Р | 8 | 50 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| SN65HVD24PE4 | ACTIVE | PDIP | Р | 8 | 50 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.





i.com 19-Mar-2008

TAPE AND REEL INFORMATION





| | Dimension designed to accommodate the component width |
|----|---|
| B0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

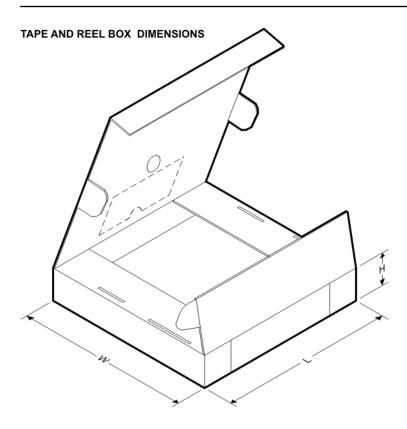
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-------------|-----------------|--------------------|---|------|--------------------------|--------------------------|---------|---------|---------|------------|-----------|------------------|
| SN65HVD20DR | SOIC | D | 8 | 2500 | 330.0 | 12.4 | 6.4 | 5.2 | 2.1 | 8.0 | 12.0 | Q1 |
| SN65HVD21DR | SOIC | D | 8 | 2500 | 330.0 | 12.4 | 6.4 | 5.2 | 2.1 | 8.0 | 12.0 | Q1 |
| SN65HVD22DR | SOIC | D | 8 | 2500 | 330.0 | 12.4 | 6.4 | 5.2 | 2.1 | 8.0 | 12.0 | Q1 |
| SN65HVD23DR | SOIC | D | 8 | 2500 | 330.0 | 12.4 | 6.4 | 5.2 | 2.1 | 8.0 | 12.0 | Q1 |
| SN65HVD24DR | SOIC | D | 8 | 2500 | 330.0 | 12.4 | 6.4 | 5.2 | 2.1 | 8.0 | 12.0 | Q1 |





*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|-------------|--------------|-----------------|------|------|-------------|------------|-------------|
| SN65HVD20DR | SOIC | D | 8 | 2500 | 340.5 | 338.1 | 20.6 |
| SN65HVD21DR | SOIC | D | 8 | 2500 | 340.5 | 338.1 | 20.6 |
| SN65HVD22DR | SOIC | D | 8 | 2500 | 340.5 | 338.1 | 20.6 |
| SN65HVD23DR | SOIC | D | 8 | 2500 | 340.5 | 338.1 | 20.6 |
| SN65HVD24DR | SOIC | D | 8 | 2500 | 340.5 | 338.1 | 20.6 |

D (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 (0,15) per end.
- Body width does not include interlead flash. Interlead flash shall not exceed .017 (0,43) per side.
- E. Reference JEDEC MS-012 variation AA.



P (R-PDIP-T8)

PLASTIC DUAL-IN-LINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MS-001

For the latest package information, go to http://www.ti.com/sc/docs/package/pkg_info.htm

IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

TI products are not authorized for use in safety-critical applications (such as life support) where a failure of the TI product would reasonably be expected to cause severe personal injury or death, unless officers of the parties have executed an agreement specifically governing such use. Buyers represent that they have all necessary expertise in the safety and regulatory ramifications of their applications, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of TI products in such safety-critical applications, notwithstanding any applications-related information or support that may be provided by TI. Further, Buyers must fully indemnify TI and its representatives against any damages arising out of the use of TI products in such safety-critical applications.

TI products are neither designed nor intended for use in military/aerospace applications or environments unless the TI products are specifically designated by TI as military-grade or "enhanced plastic." Only products designated by TI as military-grade meet military specifications. Buyers acknowledge and agree that any such use of TI products which TI has not designated as military-grade is solely at the Buyer's risk, and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI products are neither designed nor intended for use in automotive applications or environments unless the specific TI products are designated by TI as compliant with ISO/TS 16949 requirements. Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, TI will not be responsible for any failure to meet such requirements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

Products Amplifiers amplifier.ti.com Data Converters dataconverter.ti.com DSP dsp.ti.com Clocks and Timers www.ti.com/clocks Interface interface.ti.com Logic logic.ti.com Power Mgmt power.ti.com Microcontrollers microcontroller.ti.com www.ti-rfid.com RF/IF and ZigBee® Solutions www.ti.com/lprf

| Applications | |
|--------------------|---------------------------|
| Audio | www.ti.com/audio |
| Automotive | www.ti.com/automotive |
| Broadband | www.ti.com/broadband |
| Digital Control | www.ti.com/digitalcontrol |
| Medical | www.ti.com/medical |
| Military | www.ti.com/military |
| Optical Networking | www.ti.com/opticalnetwork |
| Security | www.ti.com/security |
| Telephony | www.ti.com/telephony |
| Video & Imaging | www.ti.com/video |
| Wireless | www.ti.com/wireless |

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2008, Texas Instruments Incorporated